

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	09940401	MARQUIS ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	DEVONA E FAULK	2615

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
381	315,316,323	11/9/04	DEF
381	92,122	11/23/04	DEF
455	112,113,118	1/6/05	DEF
455	69,522,68,63,71	7/3/06,8/1/06	DEF
381	79	7/13/06, 3/4/07	DEF
455	69,522	3/4/07	DEF
381	323	11/20/07	DEF
455	69,522	11/20/07	DEF
381	79,315,316,323,320,312,92,111,122	7/16/08	DEF
455	69,522,3.06	7/16/08	DEF
381	79,315,316,323,320,312,92,111,122	5/9/09	DEF
455	69,522,3.06	5/9/09	DEF

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Assignee/ Inventor search	12/10/04, 1/5/05	DEF
word search, combined class/word search	11/8,23/04,12/1 0/04	DEF
word search, combined class/word search	1/6,7/05,10/15,2 1,22/05	DEF
consulted with Ed Urban of class 455, suggested 455/69,522	7/13/06	DEF
additional search	7/11,12,13,26/0 6	DEF
additional search	8/1,4/06, 3/1` ,4/07	DEF
additonal search	11/19,20/07	DEF
additional search	7/16/08	DEF
consulted with Lewis West of class 455	7/16/08	DEF
additonal search	8/15/08	DEF
additonal search	5/9/09	DEF

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
/DEVONA E FAULK/ Examiner.Art Unit 2614			

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/DEVONA E FAULK/  
Examiner.Art Unit 2614